## Notice of References Cited Application/Control No. 10/796,186 Examiner Betelhem Shewareged Applicant(s)/Patent Under Reexamination CHEN, TENG-KUEI Page 1 of 1

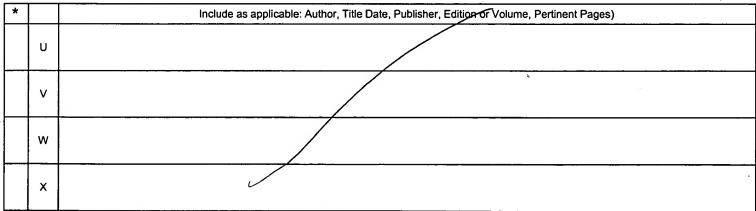
## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0035713 A1	02-2004	Chen, Teng-Kuei	205/164
	В	US-6,699,397 B1	03-2004	Chen, Teng-Kuei	216/54
	С	US-5,956,067	09-1999	Isono et al.	347/176
	D	US-5,718,523	02-1998	Shiina et al.	400/120.04
	Ε	US-5,806,999	09-1998	Kobayashi, Takehito	400/188
	F	US-5,575,507	11-1996	Yamauchi et al.	283/86
	G	US-5,344,808	09-1994	Watanabe et al.	503/227
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification				
	N									
	0					\$				
	Р									
	Q									
	R									
	S									
	Т									

## **NON-PATENT DOCUMENTS**



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